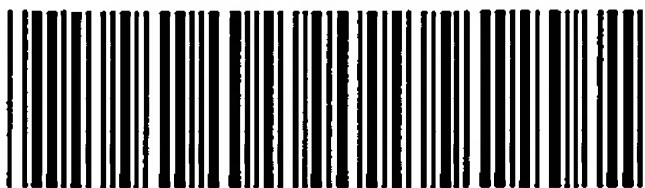


**Search Notes**

Application/Control No.

10/619,105

Examiner

Tan V. Mai

Applicant(s)/Patent under  
Reexamination

LIARDET ET AL.

Art Unit

2193

**SEARCHED**

Class	Subclass	Date	Examiner
708	200	6/30/2006	MAI

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner
PGPUB text search (see interference search printout)		6/30/2006	MAI

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
Inventor search Double Patenting Check Data Bases Search (see search history printout)	6/30/2006	MAI